



CSG10F4500

Gate Turn-off Thyristor

APPLICATION

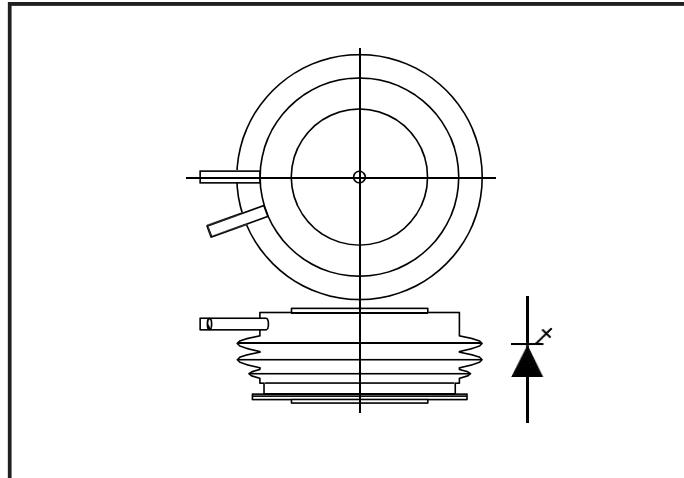
- Variable Speed AC Motor Drive Inverter (VSD-AC)
- UPS
- High Voltage Converter
- Chopper
- Welder
- Induction Heating
- DC / DC Converter

KEY PARAMETERS

I_{TCM}	1000A
V_{DRM}	4500V
$I_{T(AV)}$	320A
dV_D/dt	1000V/ μ s
di_T/dt	300A/ μ s

FEATURES

- Double Sides Cooled
- High Reliability
- High Voltage Capability
- Fast Fuse Protection Not Required
- High Surge Current Capacity
- Excellent Turn-off performance
- Reduce Equipment Size and Weight, Low noise



Outline type code: P.
See Package Details for further information.

VOLTAGE RATINGS

Mode	Repetitive Peak Off-state Voltage V_{DRM}	Repetitive Peak Reverse Voltage V_{RRM}	Test Conditions
CSG10F4500	4500	16	$T_v = 125^\circ\text{C}$, $I_{DM} = 50\text{mA}$, $I_{RRM} = 50\text{mA}$

CURRENT RATINGS

Symbol	Parameter	Test Conditions	Max.	Unit
I_{TCM}	Repetitive peak controllable on-state current	$V_D = V_{DRM}$, $T_j = 125^\circ\text{C}$, $di/dt = 30\text{A}/\mu\text{s}$, $C_s = 1.0\mu\text{F}_{\text{eq}}$	1000	A
$I_{T(AV)}$	Mean on-state current	$T_{HS} = 80^\circ\text{C}$. Double side cooled. Half sine 50Hz.	320	A
$I_{T(RMS)}$	RMS on-state current	$T_{HS} = 80^\circ\text{C}$. Double side cooled. Half sine 50Hz.	500	A



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SURGE RATINGS

Symbol	Parameter	Test Conditions	Max.	Unit
I_{TSM}	Surge (non-repetitive) on-state current	10ms half sine. $T_j = 125^\circ C$	7.0	kA
I^2t	I^2t for fusing	10ms half sine. $T_j = 125^\circ C$	0.245×10^6	A^2s
di_T/dt	Critical rate of rise of on-state current	$V_D = 3000V$, $I_T = 1000A$, $T_j = 125^\circ C$, $I_{FG} > 30A$, Rise time $> 1.5\mu s$	300	$A/\mu s$
dV_D/dt	Rate of rise of off-state voltage	To 66% V_{DRM} ; $R_{GK} \leq 1.5\Omega$, $T_j = 125^\circ C$	225	$V/\mu s$
		To 66% V_{DRM} ; $V_{RG} = -2V$, $T_j = 125^\circ C$	1000	$V/\mu s$
L_s	Peak stray inductance in snubber circuit	-	200	nH

GATE RATINGS

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
V_{RGM}	Peak reverse gate voltage	This value maybe exceeded during turn-off	-	16	V
I_{FGM}	Peak forward gate current		20	70	A
$P_{FG(AV)}$	Average forward gate power		-	10	W
P_{RGM}	Peak reverse gate power		-	15	kW
di_{GG}/dt	Rate of rise of reverse gate current		15	60	$A/\mu s$
$t_{ON(min)}$	Minimum permissible on time		20	-	μs
$t_{OFF(min)}$	Minimum permissible off time		100	-	μs

THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions		Min.	Max.	Unit
$R_{th(j-hs)}$	DC thermal resistance - junction to heatsink surface	Double side cooled		-	0.041	$^\circ C/W$
		Anode side cooled		-	0.07	$^\circ C/W$
		Cathode side cooled		-	0.1	$^\circ C/W$
$R_{th(c-hs)}$	Contact thermal resistance	Clamping force 12.0kN With mounting compound	per contact	-	0.009	$^\circ C/W$
T_{vj}	Virtual junction temperature			-	125	$^\circ C$
T_{OP}/T_{stg}	Operating junction/storage temperature range			-40	125	$^\circ C$
-	Clamping force			11.0	15.0	kN



GTO CHARACTERISTICS

$T_j = 125^\circ C$ unless stated otherwise						
Symbol	Parameters	Test Conditions	Min.	Max.	Unit	
V_{TM}	On-state voltage	At 1000A peak, $I_{G(ON)} = 4A$ d.c.	-	3.5	V	
I_{DM}	Peak off-state current	$V_{DRM} = 4500V$, $V_{RG} = 0V$	-	50	mA	
I_{RRM}	Peak reverse current	At V_{RRM}	-	50	mA	
V_{GT}	Gate trigger voltage	$V_D = 24V$, $I_T = 100A$, $T_j = 25^\circ C$	-	1.0	V	
I_{GT}	Gate trigger current	$V_D = 24V$, $I_T = 100A$, $T_j = 25^\circ C$	-	1.5	A	
I_{RGM}	Reverse gate cathode current	$V_{RGM} = 16V$, No gate/cathode resistor	-	50	mA	
E_{ON}	Turn-on energy	$V_D = 3000V$ $I_T = 1000A$, $dI_T/dt = 300A/\mu s$ $I_{FG} = 30A$, rise time < $1.5\mu s$	-	2300	mJ	
t_d	Delay time		-	1.5	μs	
t_r	Rise time		-	5.0	μs	
E_{OFF}	Turn-off energy	$I_T = 1000A$, $V_{DM} = V_{DRM}$ Snubber Cap $C_s = 1.0\mu F$, $dI_{GO}/dt = 30A/\mu s$	-	4120	mJ	
t_{gs}	Storage time		-	14.0	μs	
t_{gf}	Fall time		-	1.5	μs	
t_{gq}	Gate controlled turn-off time		-	15.5	μs	
Q_{GQ}	Turn-off gate charge		-	3000	μC	
Q_{GQT}	Total turn-off gate charge		-	6000	μC	
I_{GQM}	Peak reverse gate current		-	420	A	



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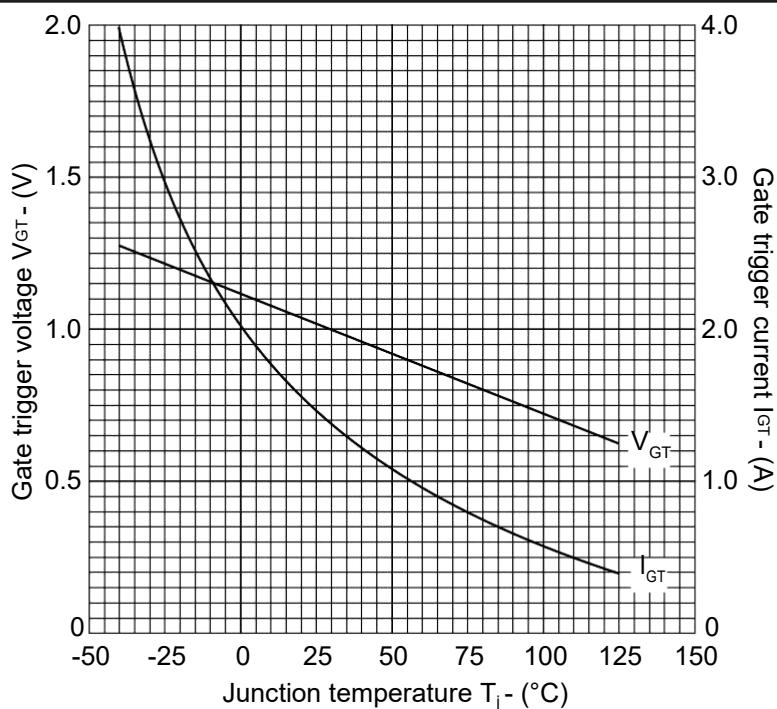


Fig.1 Maximum gate trigger voltage/current vs junction temperature

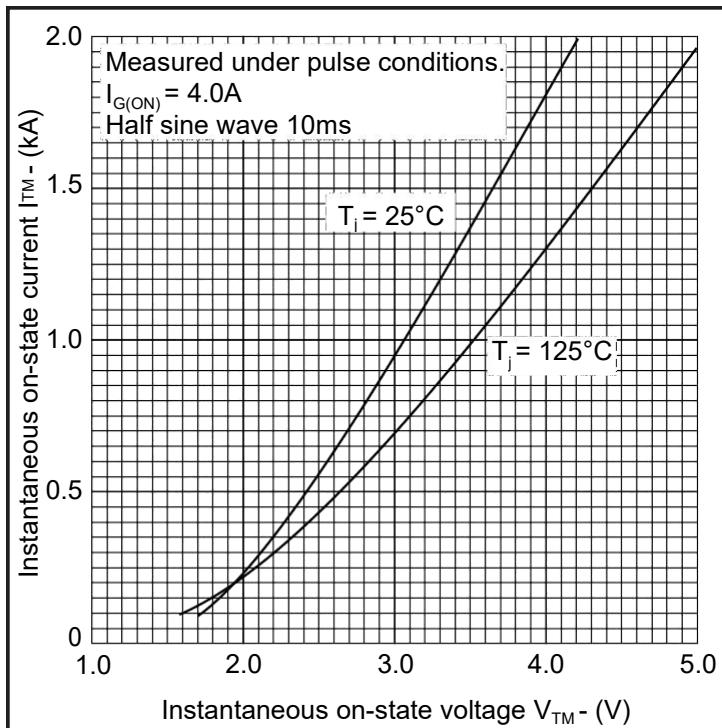
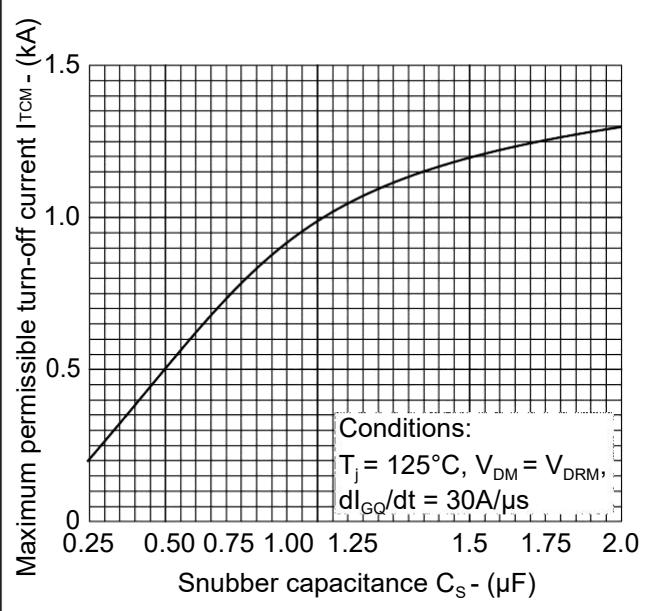


Fig.2 On-state characteristics

Fig.3 Maximum dependence of $|I_{TCM}|$ on C_S



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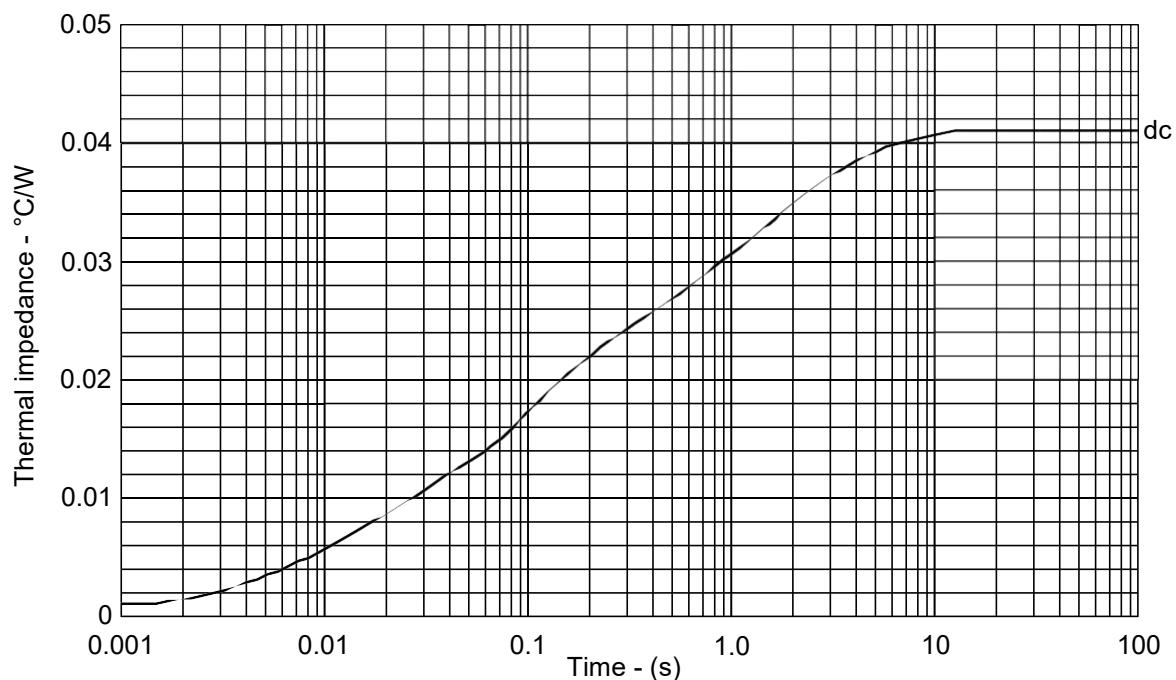


Fig.4 Maximum (limit) transient thermal impedance - double side cooled

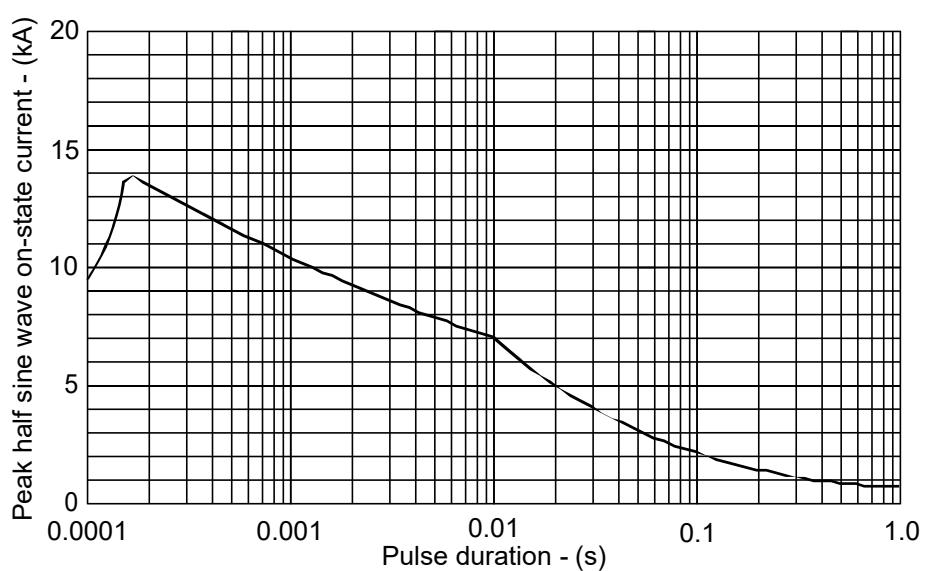


Fig.5 Surge (non-repetitive) on-state current vs time



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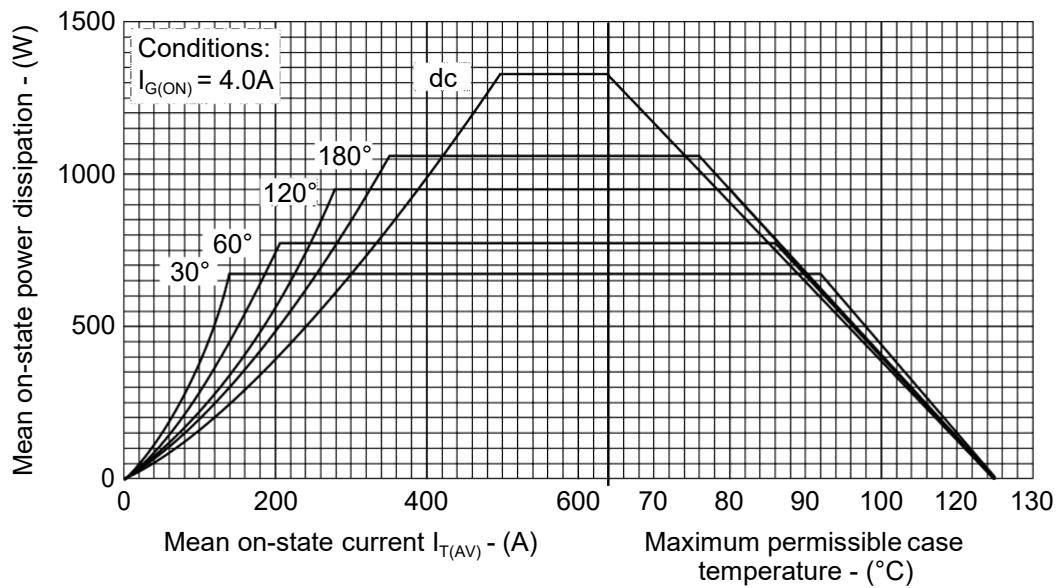


Fig.6 Steady state rectangular wave conduction loss - double side cooled

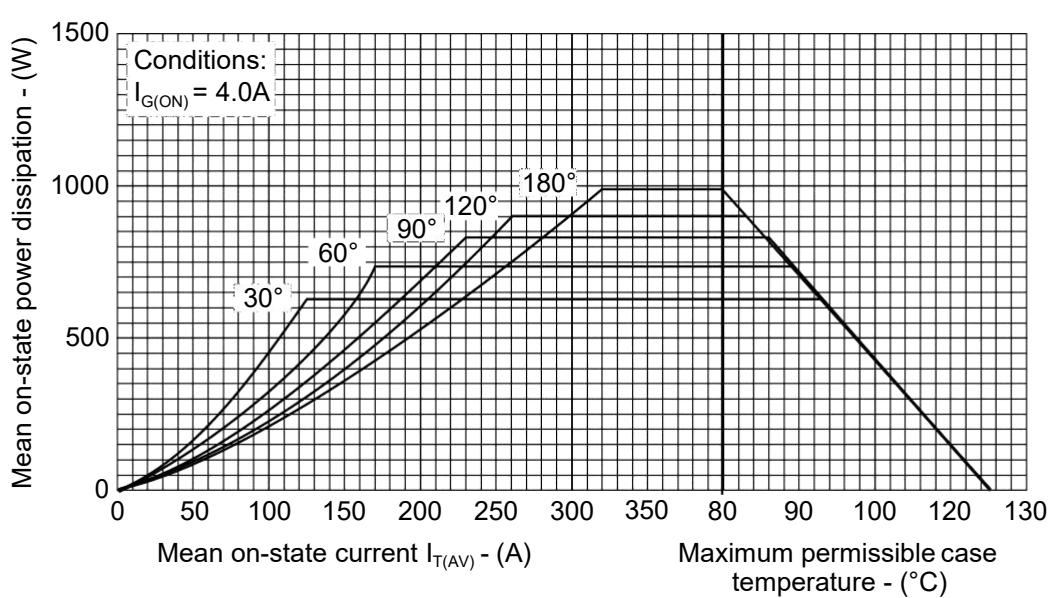


Fig.7 Steady state sinusoidal wave conduction loss - double side cooled



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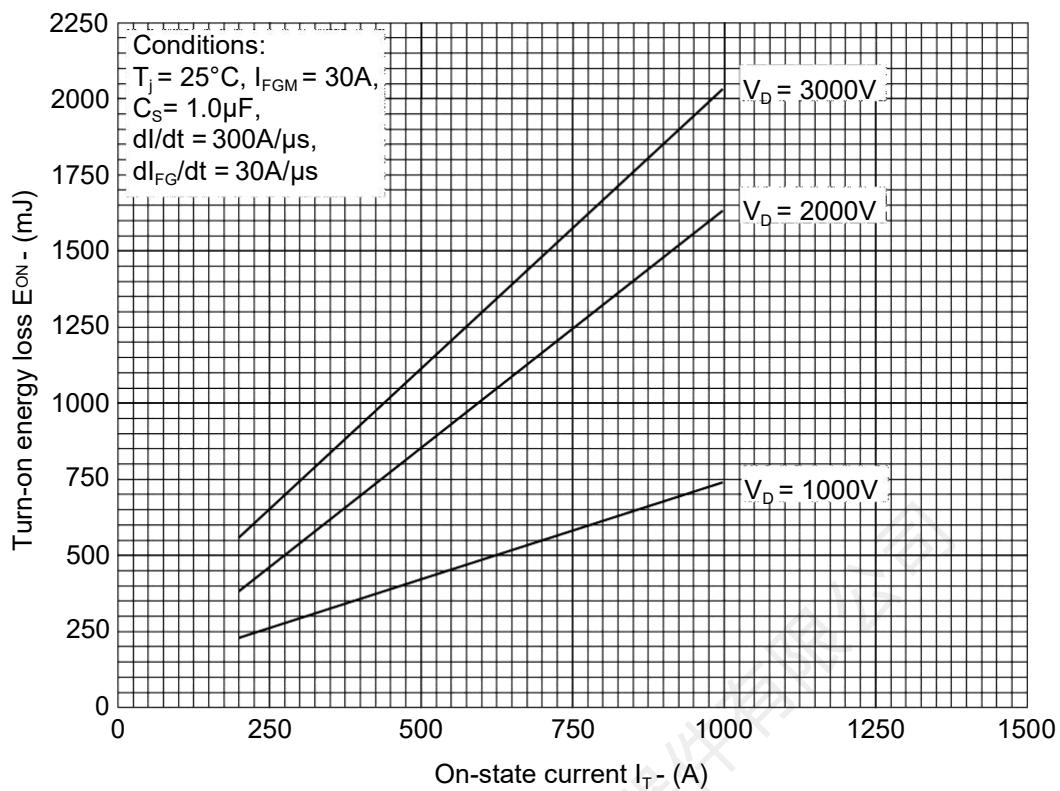


Fig.8 Turn-on energy vs on-state current

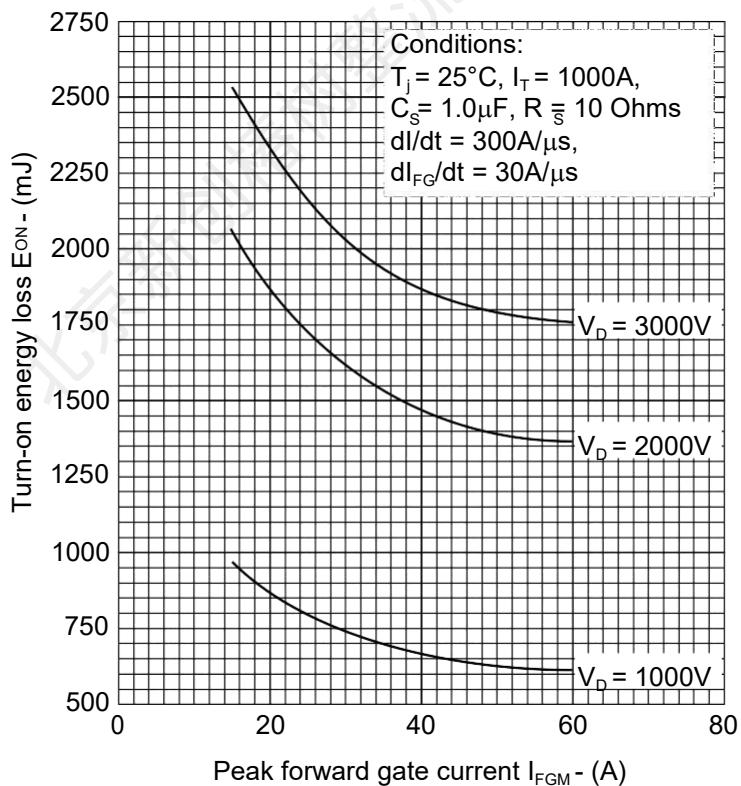


Fig.9 Turn-on energy vs peak forward gate current



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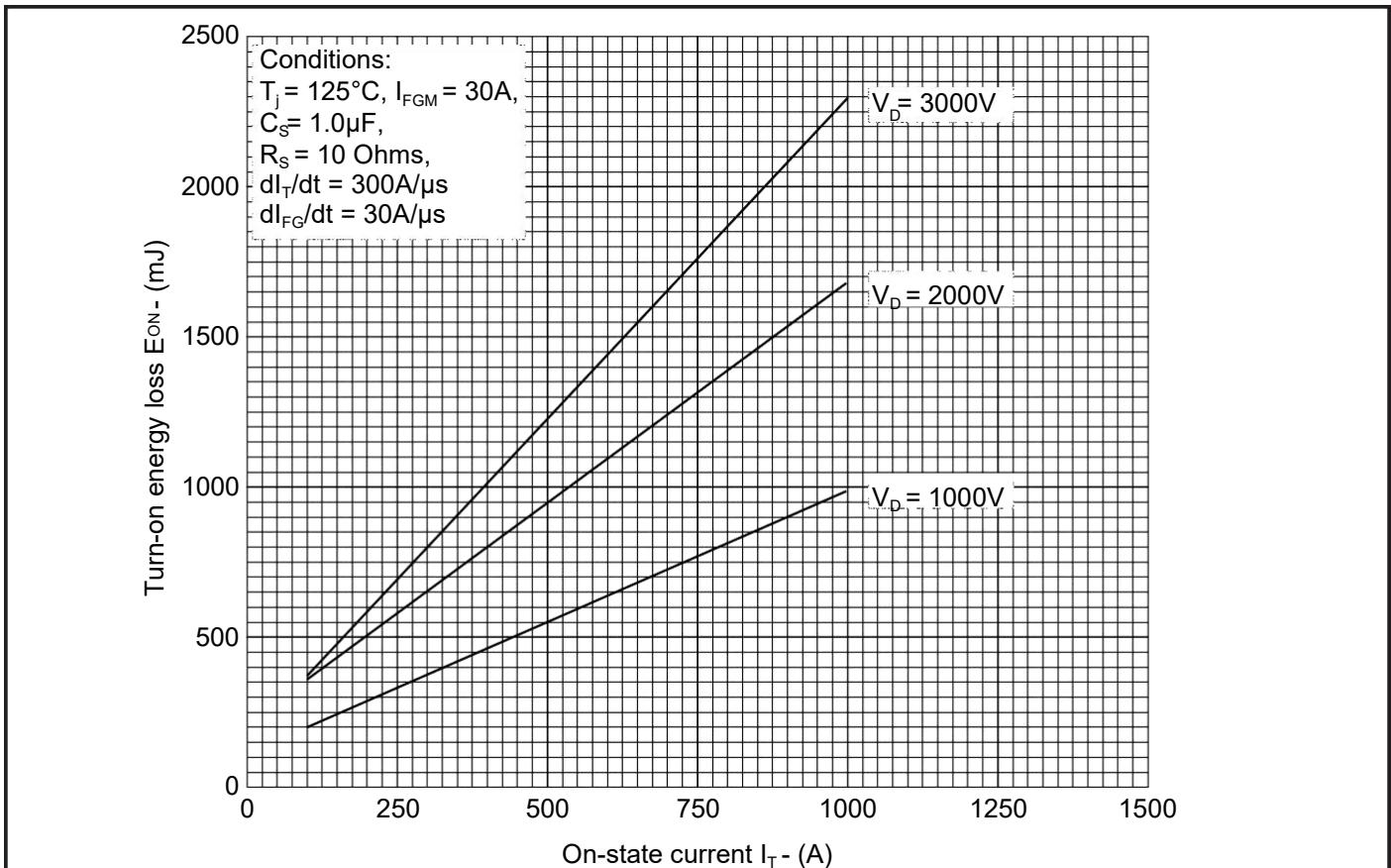


Fig.10 Turn-on energy vs on-state current

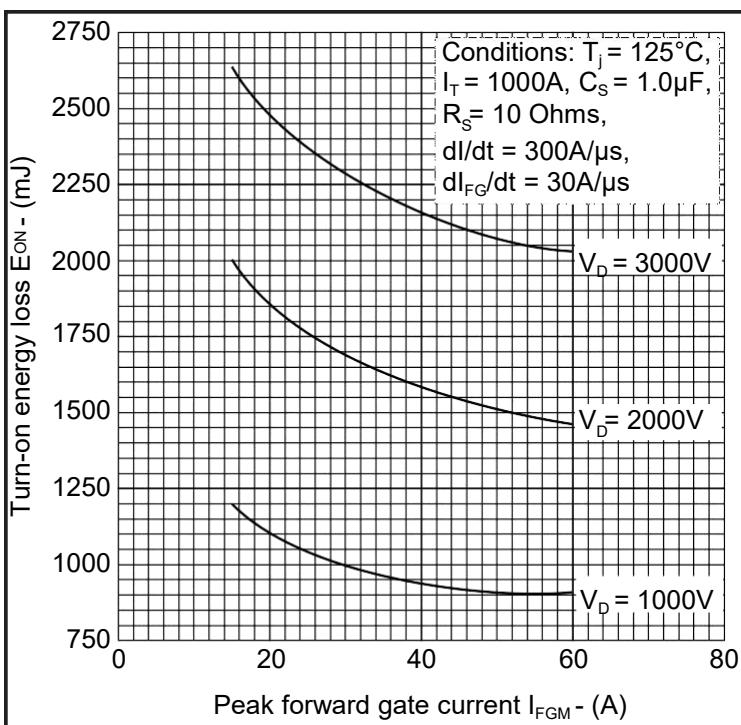


Fig.11 Turn-on energy vs peak forward gate current

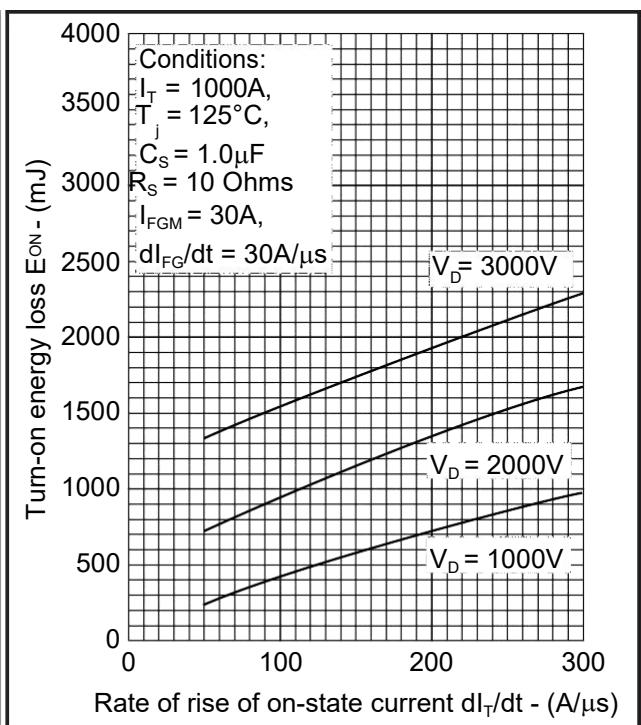


Fig.12 Turn-on energy vs rate of rise of on-statecurrent



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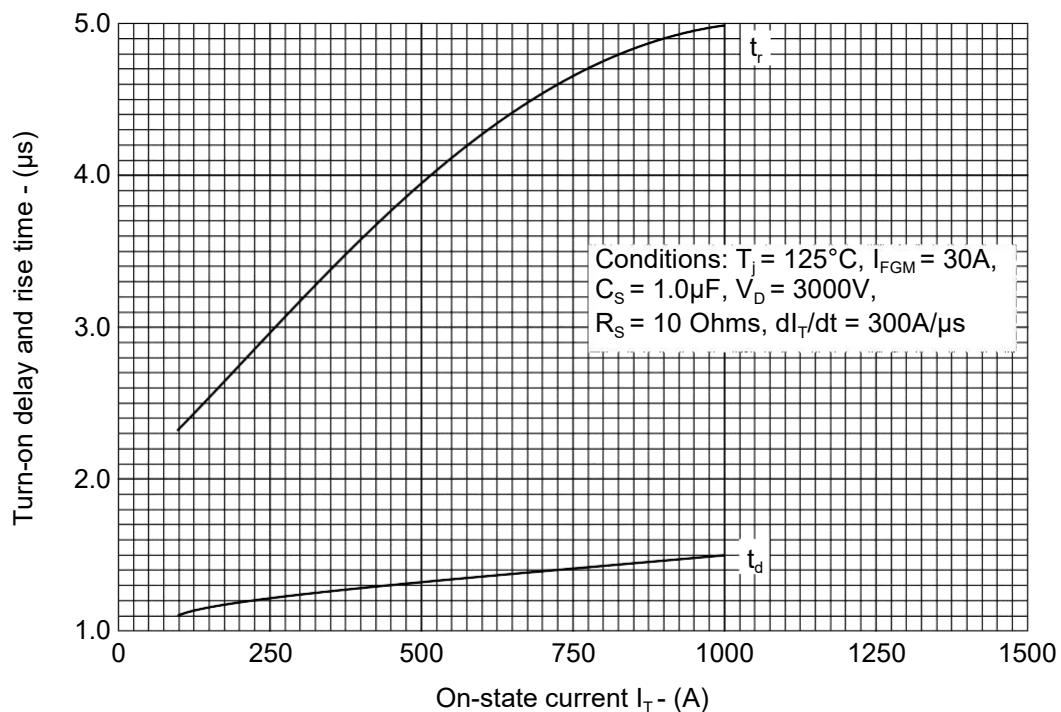


Fig.13 Delay time & rise time vs turn-on current

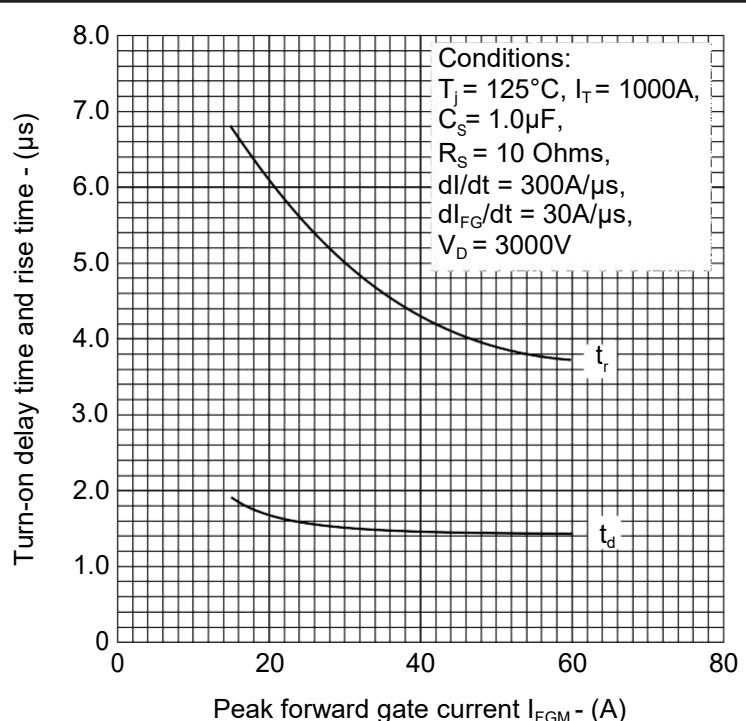


Fig.14 Delay time & rise time vs peak forward gate current



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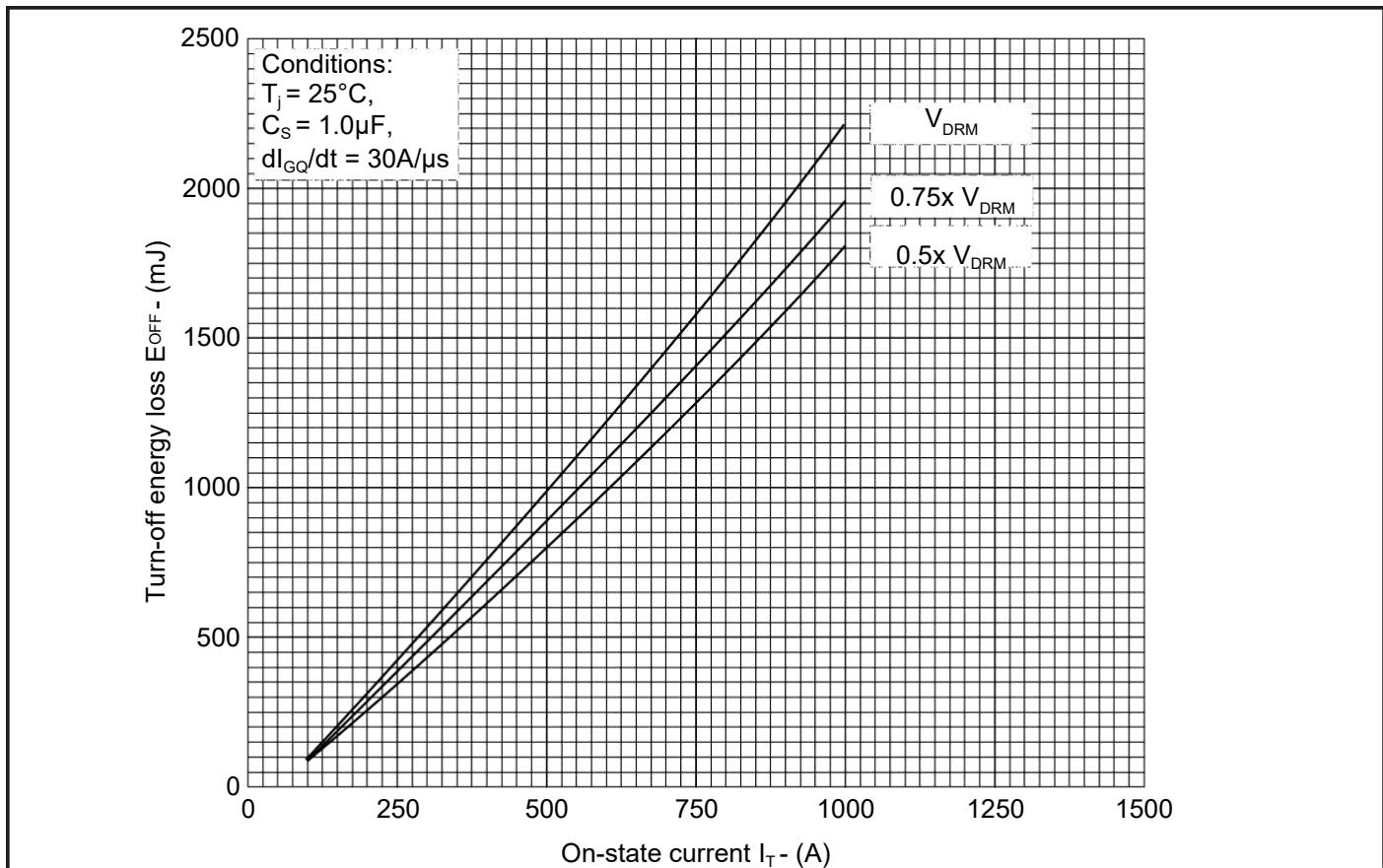


Fig.15 Turn-off energy vs on-state current

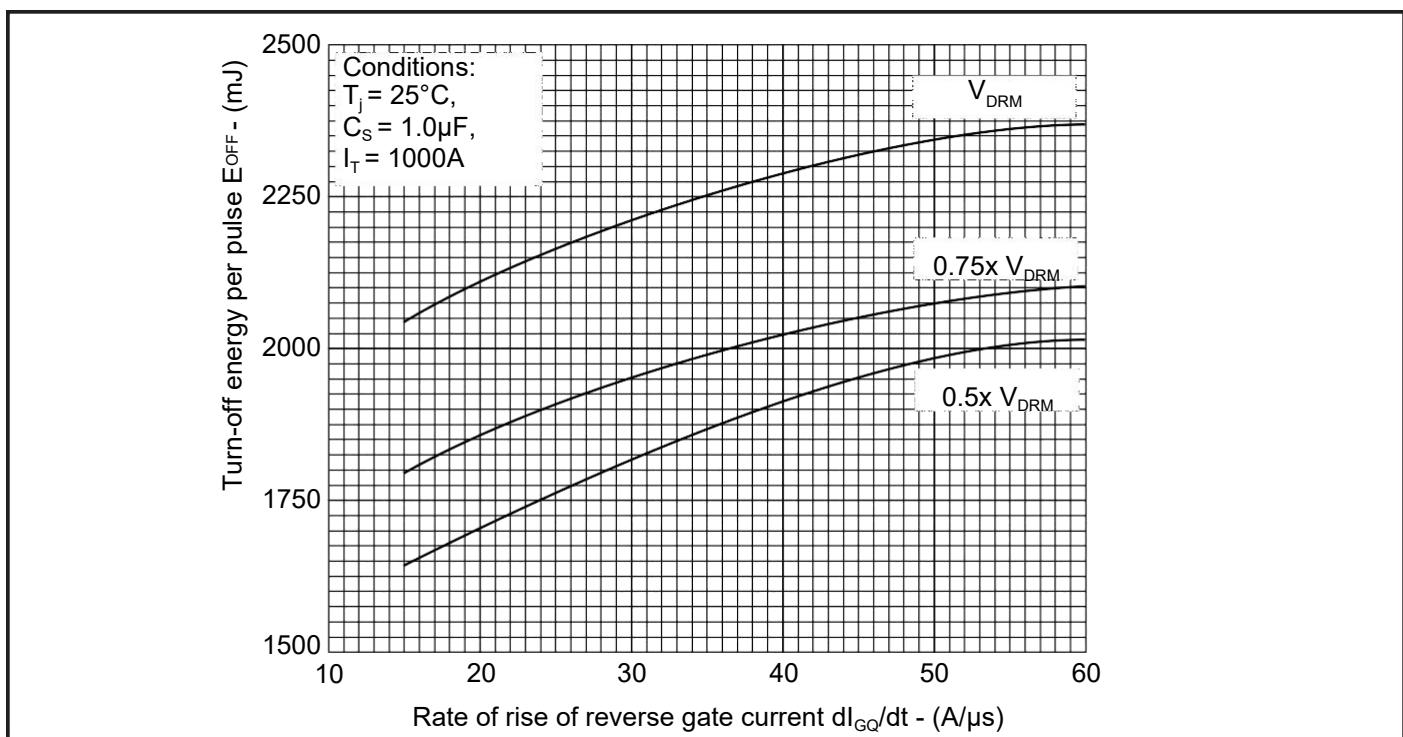


Fig.16 Turn-off energy vs rate of rise of reverse gate current



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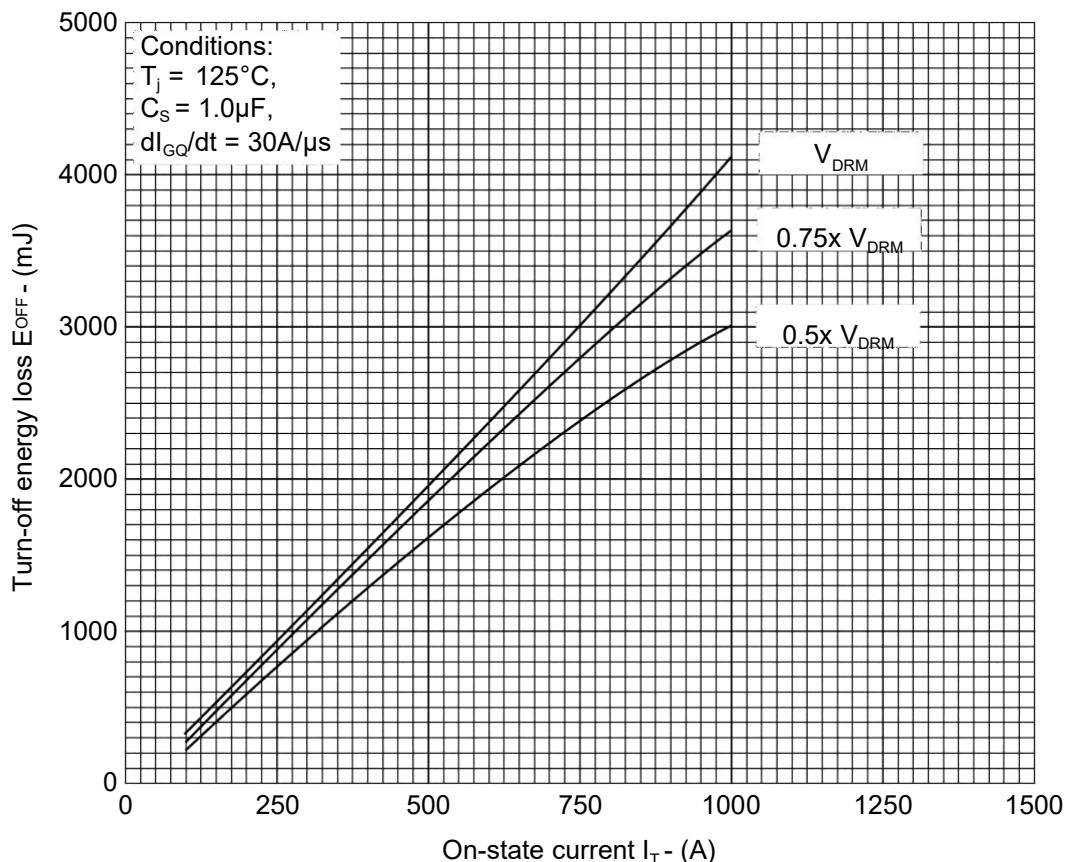


Fig.17 Turn-off energy vs on-state current

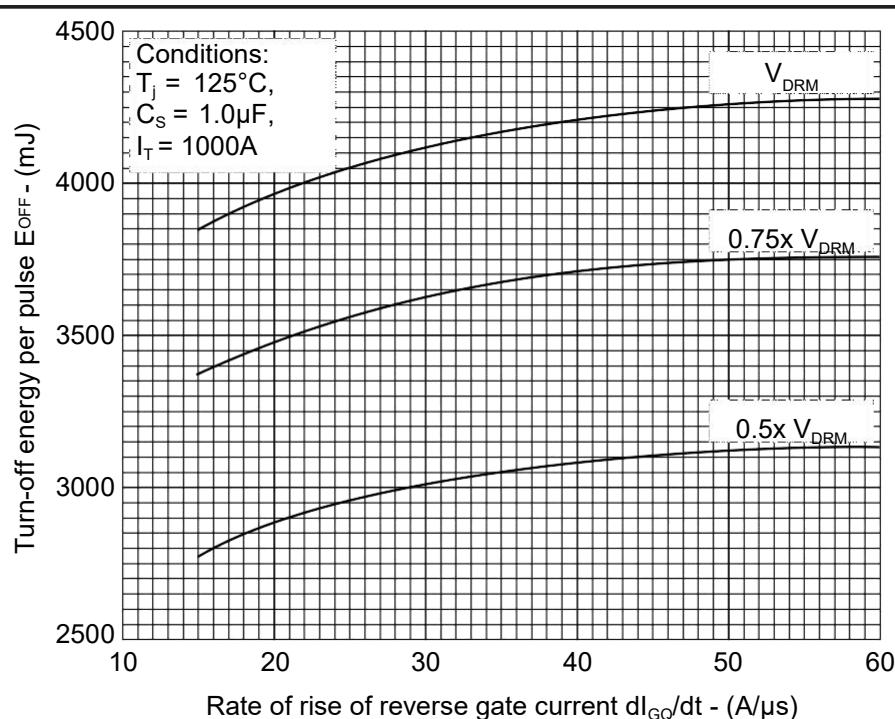


Fig.18 Turn-off energy loss vs rate of rise of reverse gate current



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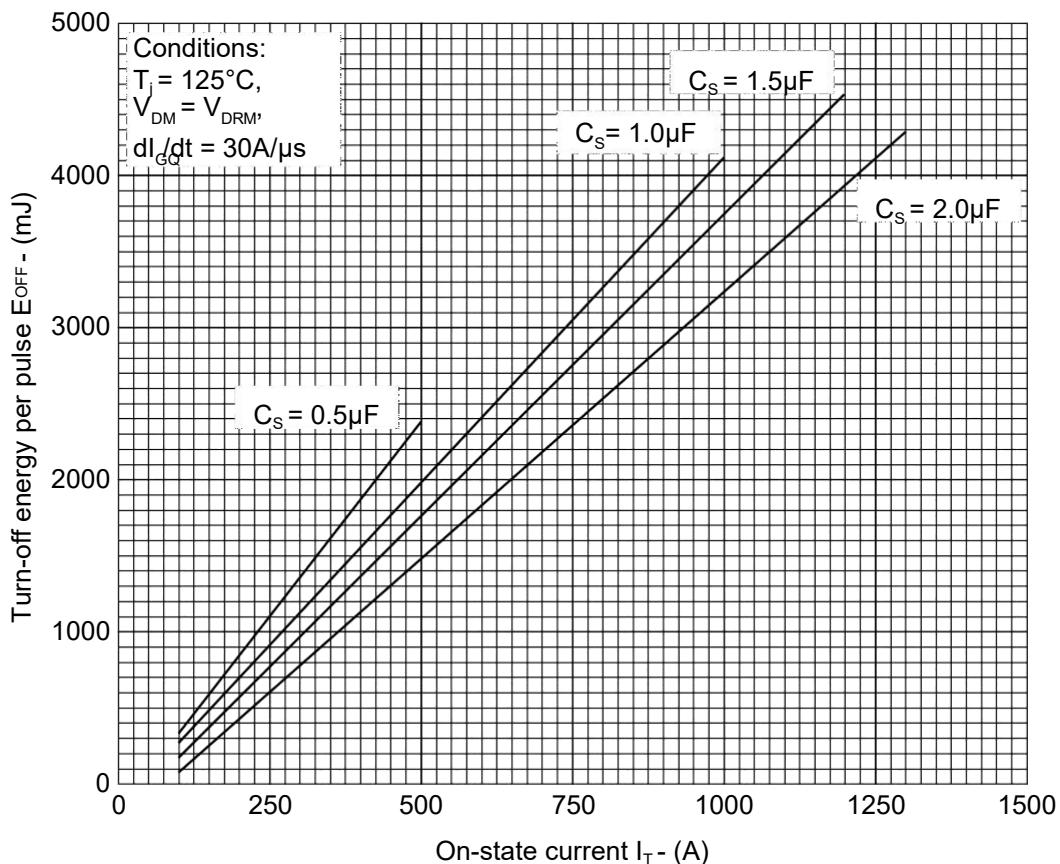


Fig.19 Turn-off energy vs on-state current

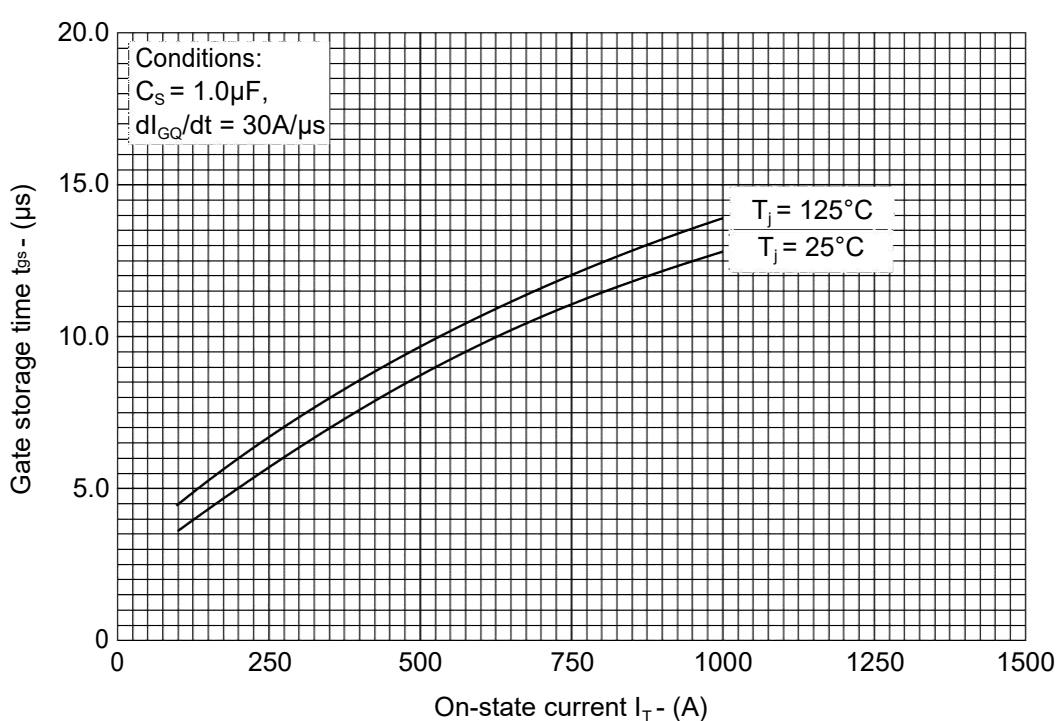


Fig.20 Gate storage time vs on-state current



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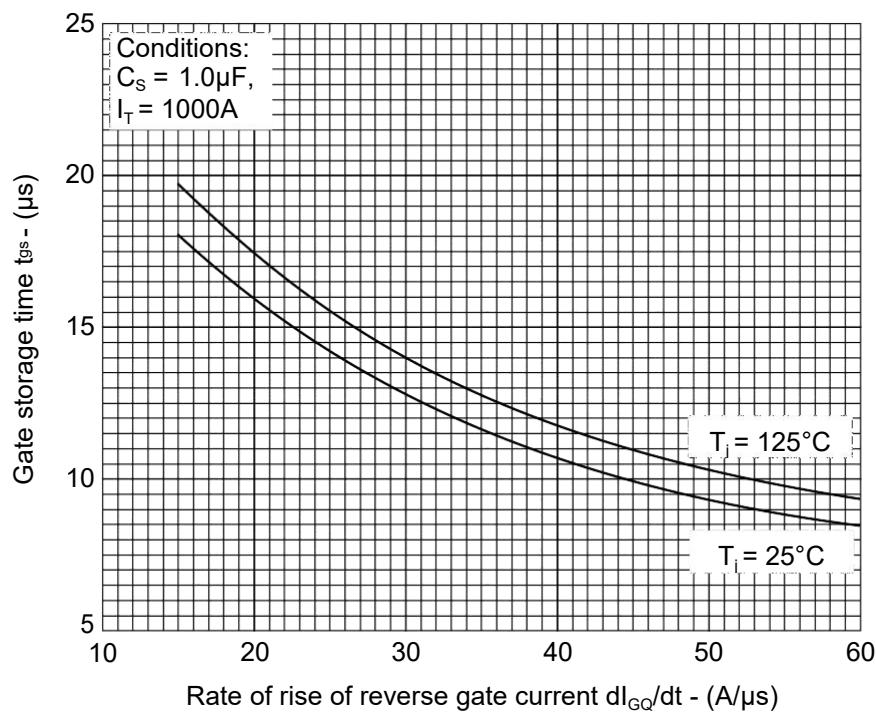


Fig.21 Gate storage time vs rate of rise of reverse gate current

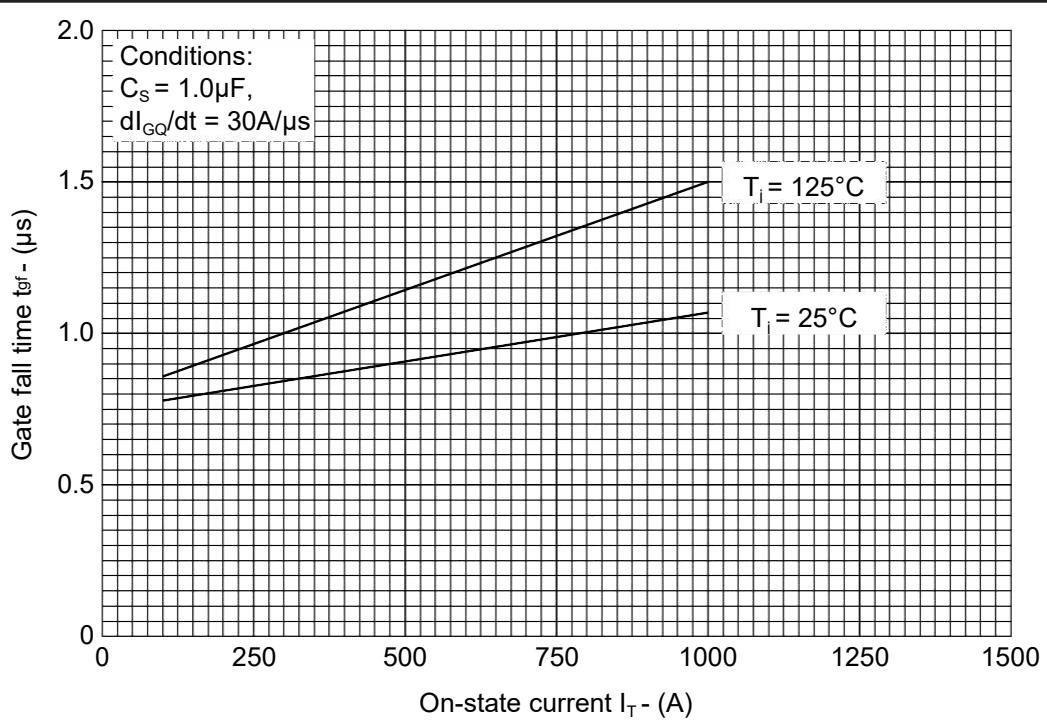


Fig.22 Gate fall time vs on-state current



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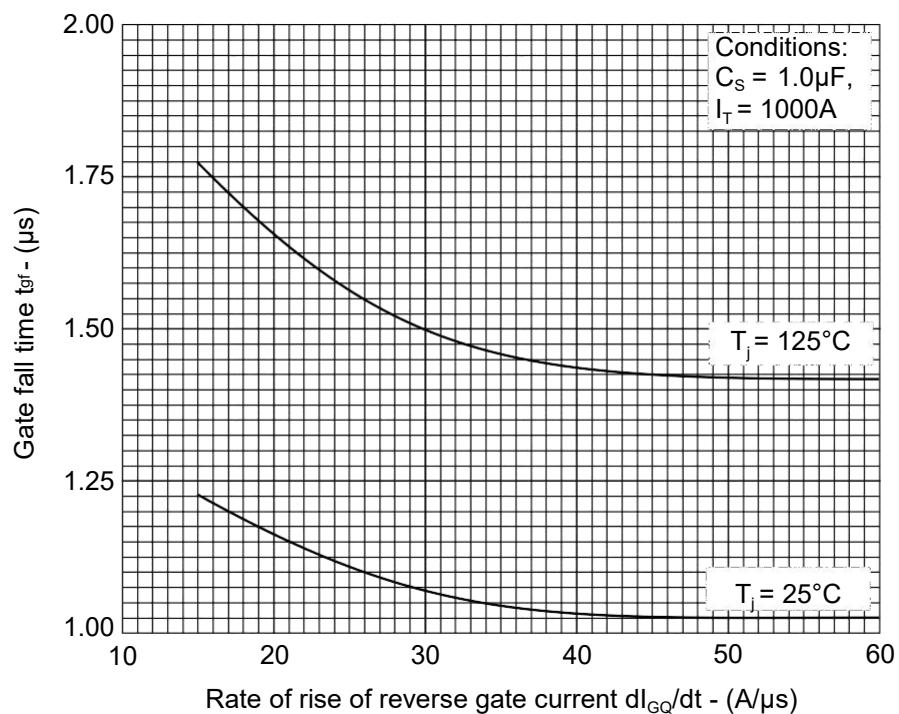


Fig.23 Gate fall time vs rate of rise of reverse gate current

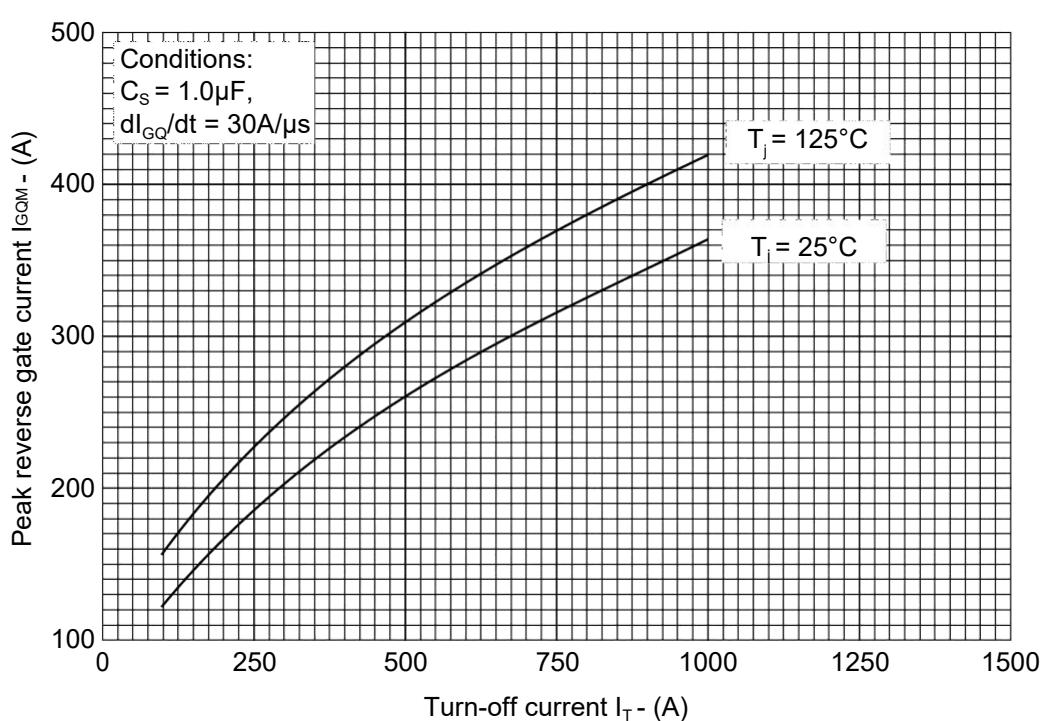


Fig.24 Peak reverse gate current vs turn-off current



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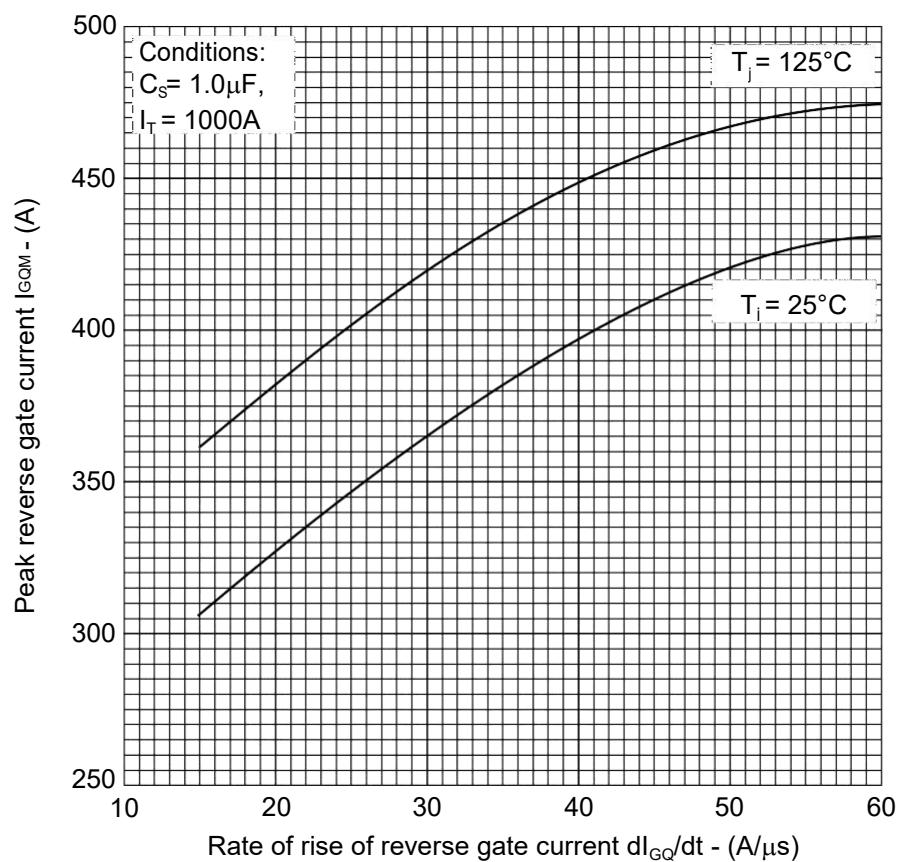


Fig.25 Peak reverse gate current vs rate of rise of reverse gate current

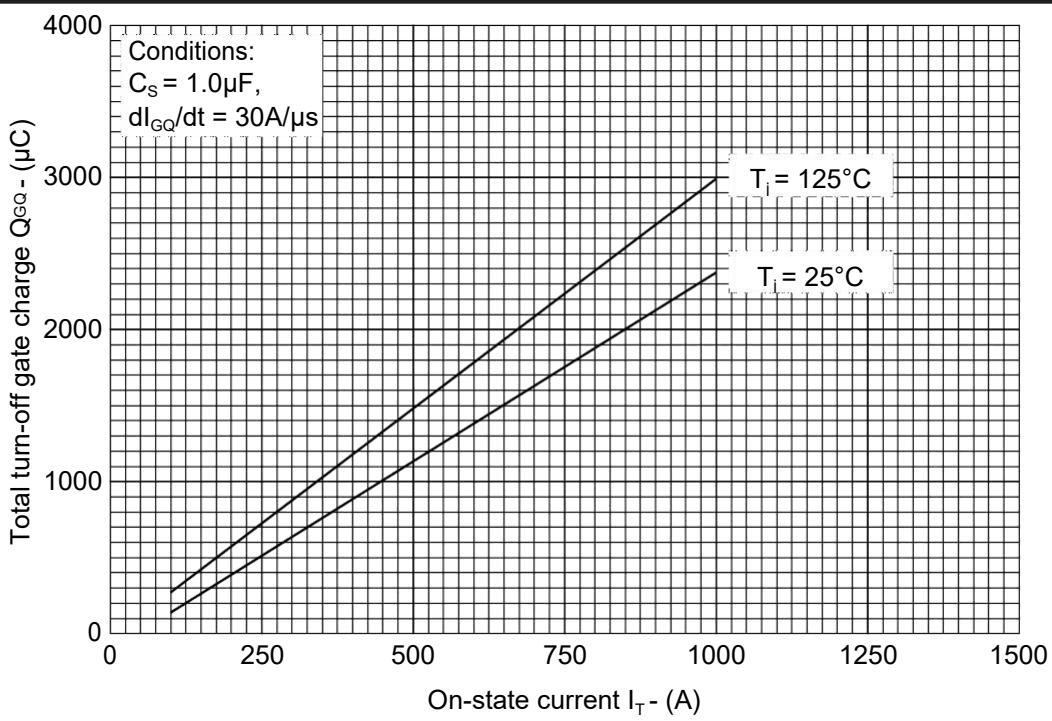


Fig.26 Turn-off gate charge vs on-state current



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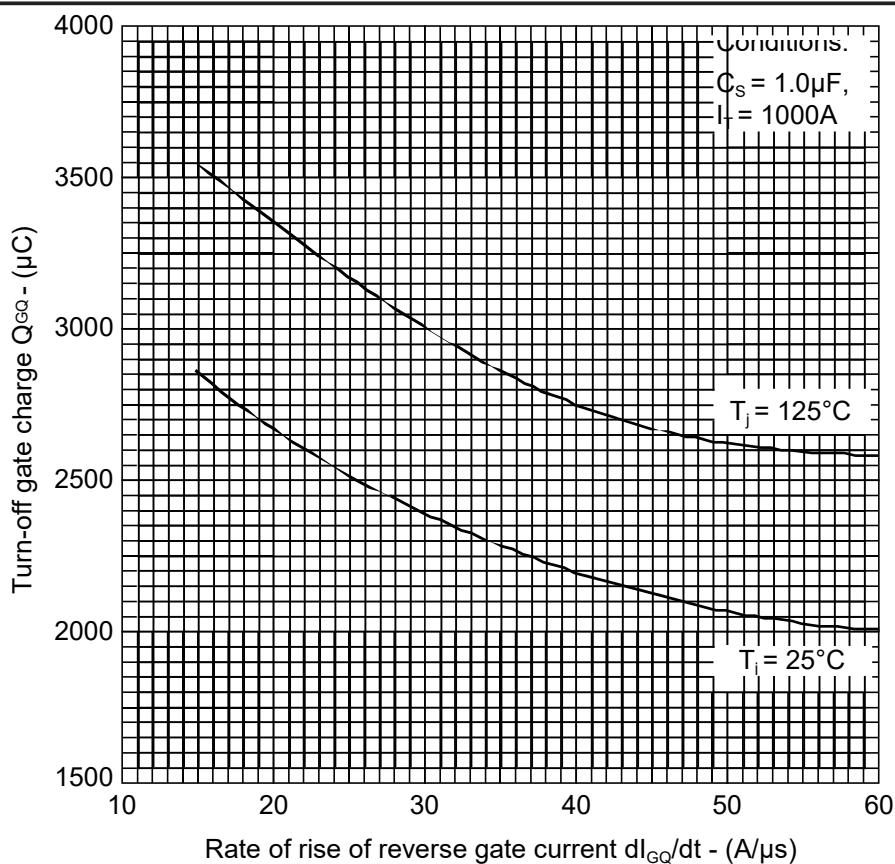


Fig.27 Turn-off gate charge vs rate of rise of reverse gate current

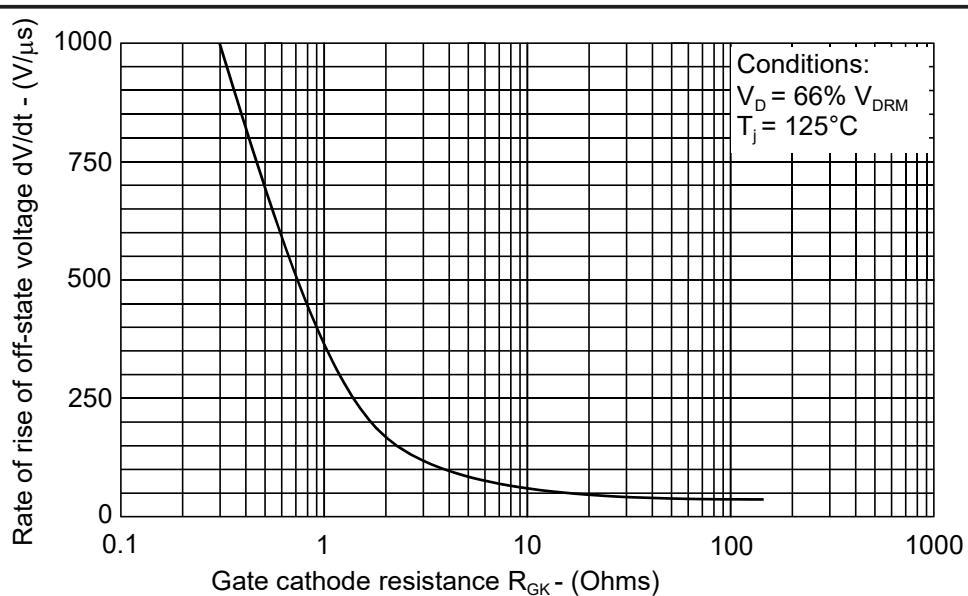
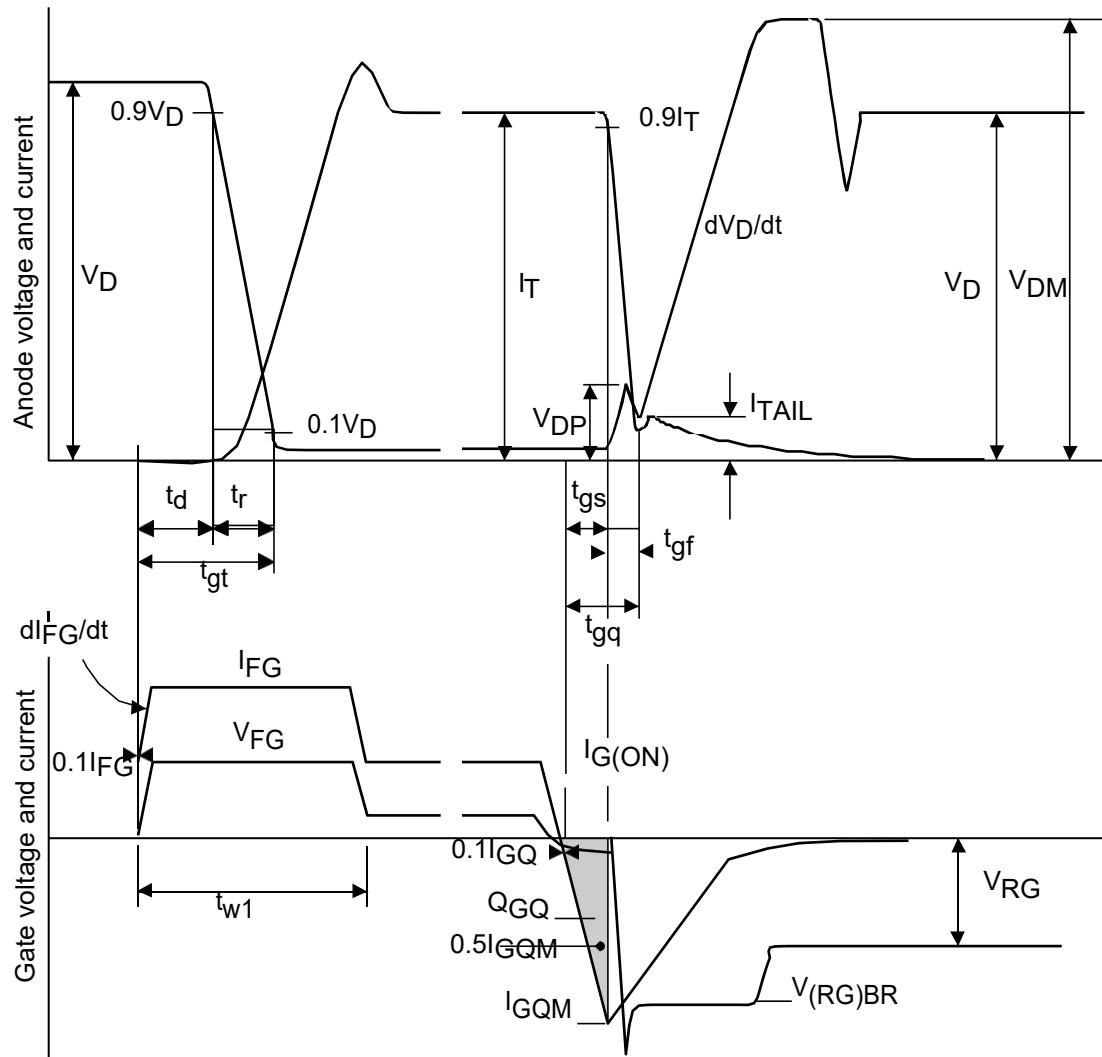


Fig.28 Rate of rise of off-state voltage vs gate cathode resistance



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Recommended gate conditions:

$$I_{TCM} = 1000A$$

$$I_{FG} = 30A$$

$$I_{G(ON)} = 4A \text{ d.c.}$$

$$t_{w1(\min)} = 20\mu s$$

$$I_{GQM} = 420A$$

$$dI_{GQ}/dt = 30A/\mu s$$

$$Q_{GQ} = 3000\mu C$$

$$V_{RG(\min)} = 2V$$

$$V_{RG(\max)} = 16V$$

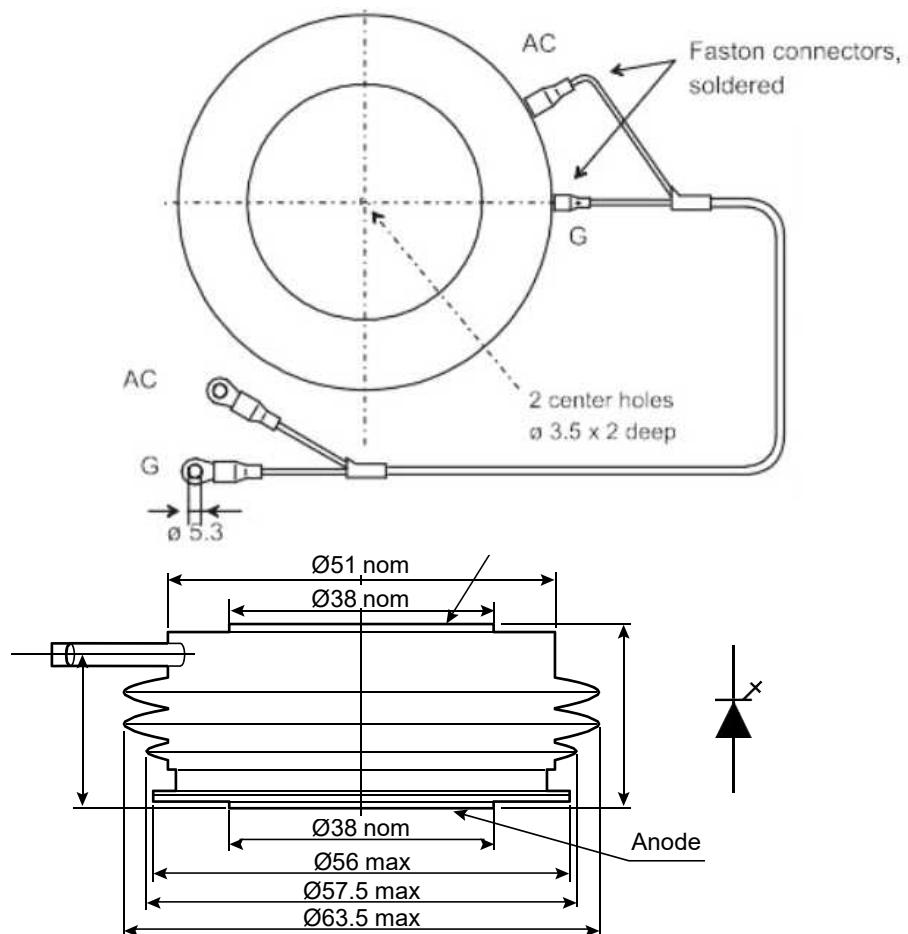
Fig.29 General switching waveforms



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OUTLINE AND DIMENSION

For further package information, please contact your local Customer Service Centre. All dimensions in mm, unless stated otherwise.
DO NOT SCALE.



Nominal weight: 350g
Clamping force: 12kN ±10%
Lead coaxial, length: 600mm

Package outline type code: P